Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/724,985	THEEL, WAYNE	
Examiner	**Art Unit**	
VanThu Nguyen	2824	

SEARCHED

Class	Subclass	Date	Examiner
365	158 o 203 x 206 209 x 230.06 x	6/15/2005	VTN
Updated	search	10/01/05	VTN

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
Same as above		10/01/05	VTN

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
EAST Search	6/15/2005	VTN
Updated EAST search	10/01/05	VTN